Application/Control No. Applicant(s)/Patent Under Reexamination 10/790,803 TANAHASHI ET AL. Notice of References Cited Examiner **Art Unit** Page 1 of 1 1762 Alain L. Bashore **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-3,868,651 02-1975 Ovshinsky, Stanford R. 365/113 Α US-В US-С US-D US-Ε US-F US-G USн US-J US-US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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